Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/676,943	OCHIAI ET AL.	
Examiner	Art Unit	
Nam Huynh	2617	

SEARCHED					
Class	Subclass	Date	Examiner		
455	420	4/27/2006	NTH		
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705	1	4/27/2006	NTH		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See EAST search notes.	4/27/2006	NTH		